Power MOSFET

30 V, 64 A, Single N-Channel, WDFN8

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- Synchronous Rectification for DC–DC Converters
- Low Side Switching
- Telecom Secondary Side Rectification

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Paran	Parameter				
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	22	А
Current R _{0JA} (Note 1)		T _A = 85°C		15.9	1
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.69	W
Continuous Drain		T _A = 25°C	۱ _D	32.4	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		23.4	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} (\text{Note 1})$	Steady	$T_A = 25^{\circ}C$	P _D	5.85	W
Continuous Drain	State	$T_A = 25^{\circ}C$	Ι _D	16.3	А
Current R _{0JA} (Note 2)		$T_A = 85^{\circ}C$		11.7	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	1.47	W
Continuous Drain		T _C = 25°C	I _D	64	А
Current R _{0JC} (Note 1)		$T_C = 85^{\circ}C$		46	
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_C = 25^{\circ}C$	PD	22.73	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	192	А
Operating Junction and S	Storage Ten	nperature	T _J , T _{stg}	–55 to +150	°C
Source Current (Body Die	ode)		۱ _S	32	А
Drain to Source dV/dt		dV/dt	6.0	V/ns	
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, \text{ V}_L = 32 \text{ A}_{pk}, L = 0.1 \text{ mH}, \text{ F}$	E _{AS}	52	mJ		
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size of 90 mm².

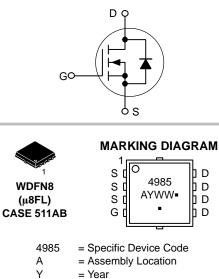


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	3.5 mΩ @ 10 V	64 A
30 V	5.2 mΩ @ 4.5 V	0 4 A

N-Channel MOSFET



(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

WW

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4985NFTAG	WDFN8 (Pb–Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ extsf{ heta}JC}$	5.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	R_{\thetaJA}	46.4	
Junction-to-Ambient - Steady State (Note 4)	R_{\thetaJA}	84.8	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	R_{\thetaJA}	21.4	

Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size of 90 mm².

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$V_{GS} = 0 V,$ $V_{DS} = 24 V$ $T_{J} = 25^{\circ}C$			500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)							

Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.2	1.6	2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V 40.V	I _D = 20 A		2.8	3.5	mΩ
		V _{GS} = 10 V	I _D = 10 A		2.8		
			I _D = 20 A		4.16	5.2	
		V _{GS} = 4.5 V	I _D = 10 A		4.13		
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D =	= 10 A		34		S

CHARGES AND CAPACITANCES

Input Capacitance	C _{iss}		2075	pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V	876	
Reverse Transfer Capacitance	C _{rss}	1	46	
Total Gate Charge	Q _{G(TOT)}		13.6	nC
Threshold Gate Charge	Q _{G(TH)}		2.0	
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 20 A	5.8	
Gate-to-Drain Charge	Q _{GD}	1	4.1	
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 20 A	29.4	nC

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t _{d(on)}		11	ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	24	
Turn–Off Delay Time	t _{d(off)}	$I_{\rm D}$ = 15 A, R _G = 3.0 Ω	20	
Fall Time	t _f		5.4	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)						
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			8.5		ns
Rise Time	t _r				24		
Turn–Off Delay Time	t _{d(off)}	$I_{\rm D} = 15 \rm A, R_{\rm G}$	= 3.0 Ω		25		
Fall Time	t _f	1			4.0		
DRAIN-SOURCE DIODE CHARA	CTERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V.$ $T_{J} = 25^{\circ}C$			0.4	0.7	V
		$V_{GS} = 0 V,$ $I_{S} = 2 A$ $T_{J} = 125^{\circ}C$ $T_{J} = 125^{\circ}C$	T _J = 125°C		0.33		
Reverse Recovery Time	t _{RR}		•		35.7		ns
Charge Time	t _a	$V_{GS} = 0 V_{t} d_{1S}/d_{t}$	= 100 A/us,		18.2		
Discharge Time	t _b	$V_{GS} = 0 V, d_{IS}/d_t$ $I_S = 2 V$	A L		17.5		
Reverse Recovery Charge	Q _{RR}				32		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.65		nH
Drain Inductance	L _D				0.20		
Gate Inductance	L _G	$T_{A} = 25^{\circ}$	τ. ·		1.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width = $300 \ \mu$ s, duty cycle $\leq 2\%$.

1.0

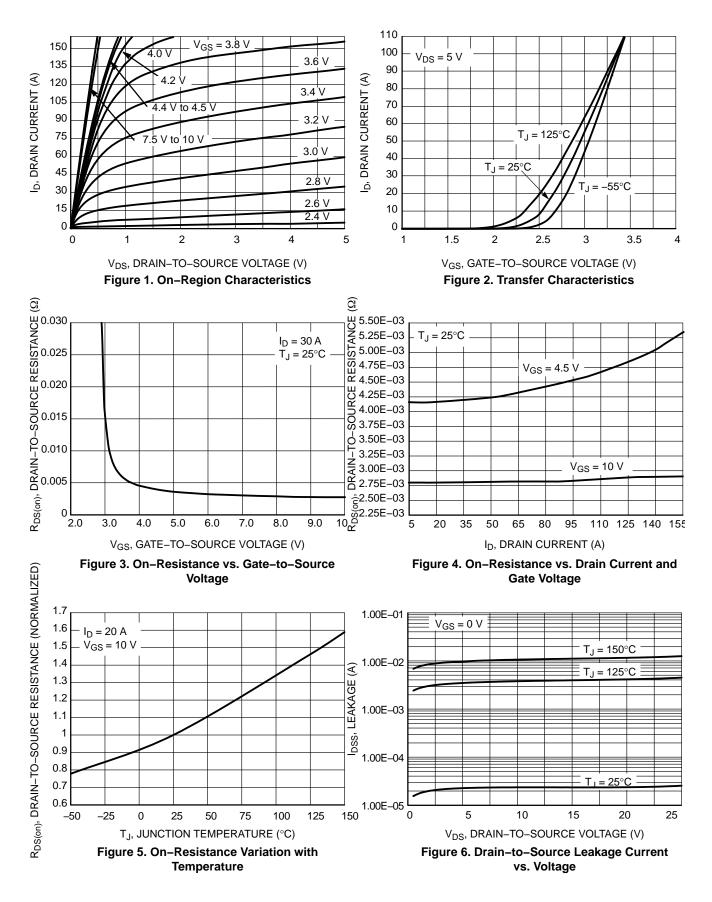
Ω

Gate Resistance

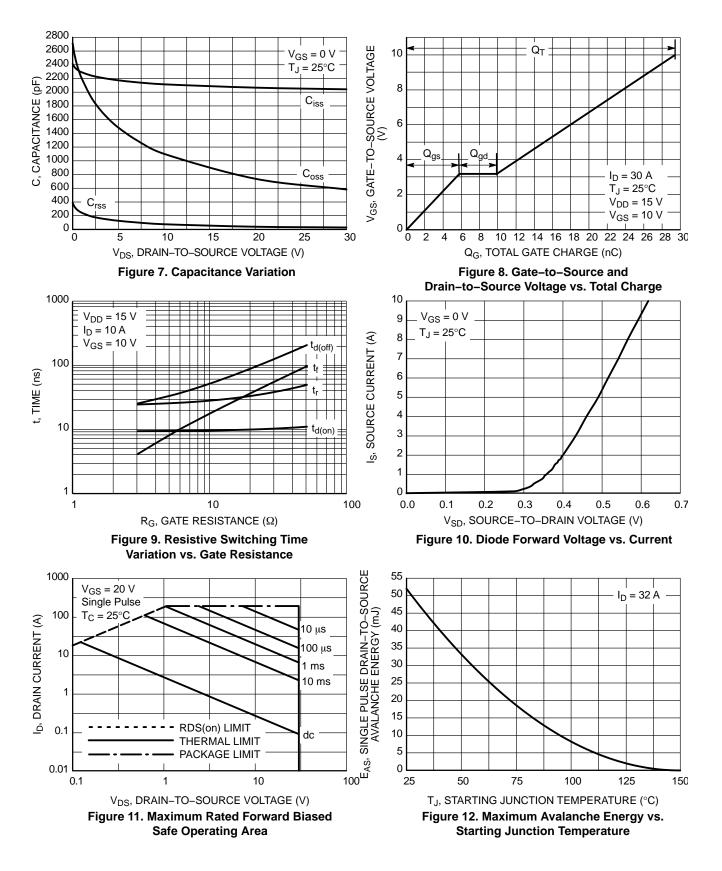
6. Switching characteristics are independent of operating junction temperatures.

R_G

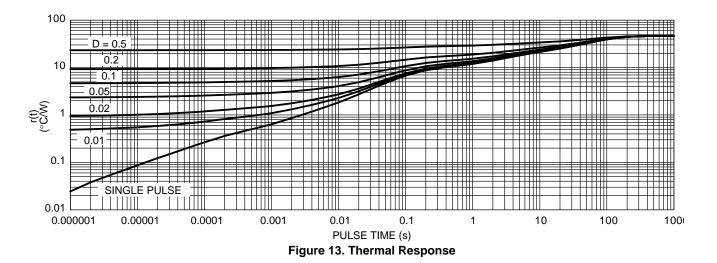
TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



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PACKAGE DIMENSIONS

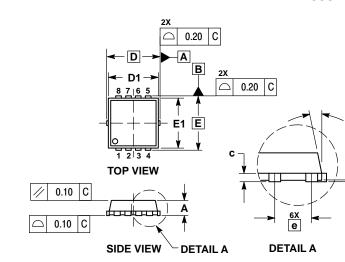
WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

A

A1

С

SEATING PLANE



С A В 0.10 \oplus 0.05 С e/2 4X Ā ₽ E2 F3 м ¥ D2 G **BOTTOM VIEW**

NOTES

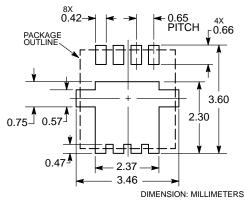
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DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. 1. 2.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
q	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC	;	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е	3.30 BSC			0	.130 BSC)	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
e	0.65 BSC			(0.026 BS0	0	
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
Г	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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